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High Efficiency Photocatalytic Activity of Type-II SnO/Sn₃O₄ Heterostructures via Interfacial Charge Transfer

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Abstract

Flower-like hollow microspheres were synthesized on a large scale using a one-step hydrothermal route. The as-prepared products were characterized by X-ray diffraction (XRD), scanning electron microscopy (SEM), high resolution transmission electron microscopy (HRTEM), X-ray photoelectron spectroscopy (XPS), and UV-vis diffuse reflectance spectroscopy. The results showed that the shells of the hollow microspheres were composed of numerous type-II SnO/Sn₃O₄ heterostructures. A 500 °C annealing treatment changed the type-II SnO/Sn₃O₄ heterostructures into type-I SnO₂/Sn₃O₄ heterostructures; at 700 °C, the products were pure SnO₂ semiconductors. A photocatalytic degradation test showed that the highest efficiency degradation of rhodamine B (RhB) was obtained using type-II SnO/Sn₃O₄ heterostructure semiconductors with a degradation rate constant of $2.3 \times 10^{-3} \text{ min}^{-1}$. This highly efficient activity was induced by enhanced charge separation in type-II SnO/Sn₃O₄ heterostructure semiconductors.

Keywords: SnO/Sn₃O₄, SnO₂/Sn₃O₄, heterostructures, photocatalytic degradation

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1 I. Introduction

2 In recent years, univalent tin oxides, such as SnO₂ and SnO, have attracted considerable
3 interest as research subjects because of their wide ranging applications to lithium-ion
4 batteries^{1,2}, sensitized solar cells^{3, 4}, chemical and biological sensors^{5, 6} and photocatalysts^{7, 8,}
5 ^{9, 10}. In addition to univalent tin oxides, heterovalent tin oxides (e.g., Sn₃O₄, Sn₂O₃, and Sn₅O₆)
6 with a variety of coordination structures have been a popular subject in both theoretical
7 calculations and experimental studies on regulating the Sn(II)/Sn(IV) ratio^{11, 12}. Moreover,
8 heterovalent tin structures have been reported to influence the physical properties of tin
9 oxides. *Park et al.* found that heterovalent tin oxide exhibits more sensitivity for CH₂Cl₂
10 detection than either SnO or SnO₂ univalent oxides¹³. Theoretical calculations have confirmed
11 that Sn₃O₄ has absorption bands that enable its use as a visible-light-driven photocatalyst for
12 environmental remediation¹⁴.

13 A univalent tin oxide-based composite, which includes SnO₂ and SnO, is a wide band
14 gap semiconductor (SnO₂: $\approx 3.5\text{eV}$, RT, SnO: $\approx 2.7\text{eV}$, RT) and exhibits good activity and
15 stability under irradiation in both acidic and basic media. However, there have been few
16 reports on the direct use of pure tin oxide-based materials as photocatalysts, and it is
17 well-known that SnO₂ exhibits low photocatalytic activity even under UV irradiation because
18 of its its large band gap^{15, 16}. Currently, there are primarily two popular strategies that have
19 been pursued in the literature to improve the photocatalytic activity of SnO₂. One strategy is
20 to design various geometries and morphologies for tin oxide-based photocatalysis, because
21 catalytic activity depends on the structural parameters of SnO₂ such as geometry, morphology,
22 etc., and many complex nanostructures with novel geometry and morphology have been
23 abundantly documented¹⁷. Among the aforementioned nanostructures, hollow structures of tin
24 oxide-based architectures have also been extensively investigated for their large catalytically
25 active surface area, high organic pollutant adsorption and the excellent incident light
26 scattering within the structures¹⁸. Although considerable progress has been made in the
27 synthesis of hollow spheres^{19, 20}, it is still a major challenge to develop a facile route for the
28 preparation of tin oxide hollow nanostructures with the desired optical properties, especially a
29 one-step synthesis of a hollow structure. However, this strategy does not fundamentally solve

1 the problem of the fast recombination of photogenerated electron-hole pairs that hinder the
2 industrial application of photocatalytic techniques. Thus, minimizing the recombination of
3 photogenerated electron-hole pairs before they participate in redox processes is critical for
4 enhancing photocatalytic efficiency. A novel development has been the synthesis of tin
5 oxide-based photocatalysts using lower band gap semiconductors to form heterostructures
6 (e.g., $\text{SnO}_2/\text{TiO}_2$ ^{21, 22}, SnO_2/ZnO ^{23, 24}, $\text{SnO}_2/\text{SnS}_2$ ²⁵, and SnO_2/Cd ²⁶, $\text{SnO}_2\text{-CdSe}$ ²⁷). Among
7 these heterostructures, type-II heterostructures are ideal for photocatalytic reactions in which
8 both rapid charge separation and low radiative recombination efficiency are required. The
9 improved photocatalytic activity of the hetero-junctions has also attributed to a large extent to
10 the enhanced separation of photo-induced electrons and holes via interfacial charge transfer.
11 Photocatalytic activity can be enhanced by the type-II heterostructures that are formed using
12 two types of semiconductors; however, the fabrication of these structures is complex because
13 two steps are usually required.

14 The close correlation between shape and morphology and the use of heterogeneous
15 photocatalysts makes the facile fabrication of desirable hollow nanoarchitectures of tin oxides
16 heterostructures a strongly desirable goal. Heterovalent tin oxides (e.g., Sn_3O_4 , Sn_2O_3 , and
17 Sn_5O_6) exhibit a narrower band gap than that of univalent tin oxides^{28,29} and are thus
18 candidates for producing heterostructures of type-II univalent tin oxides. To the best of our
19 knowledge, this study is the first time that photocatalytic activity has been reported for
20 heterostructures of a homologous series of tin oxides. Herein, we report a simple one-step
21 hydrothermal route to fabricate $\text{SnO}/\text{Sn}_3\text{O}_4$ and $\text{SnO}_2/\text{Sn}_3\text{O}_4$ hetero-junctions for use as
22 photocatalysts. Heterostructures of homologous tin oxides exhibit excellent photocatalytic
23 performance. Notably, the annealing temperature can be simply tuned to easily control the
24 density of the heterostructures and the band structure of tin oxides, thereby improving the
25 optical properties of these materials. The heterostructures of tin oxides exhibit a much higher
26 efficiency than pure SnO_2 for the degradation of rhodamine B (RhB). Moreover, this simple
27 one-step hydrothermal route offers a wide range of practical applications and is a good
28 strategy for employing heterovalent tin oxide to fabricate a homologous series of tin oxides
29 for use as photocatalysts.

30

1 II. Experimental Section

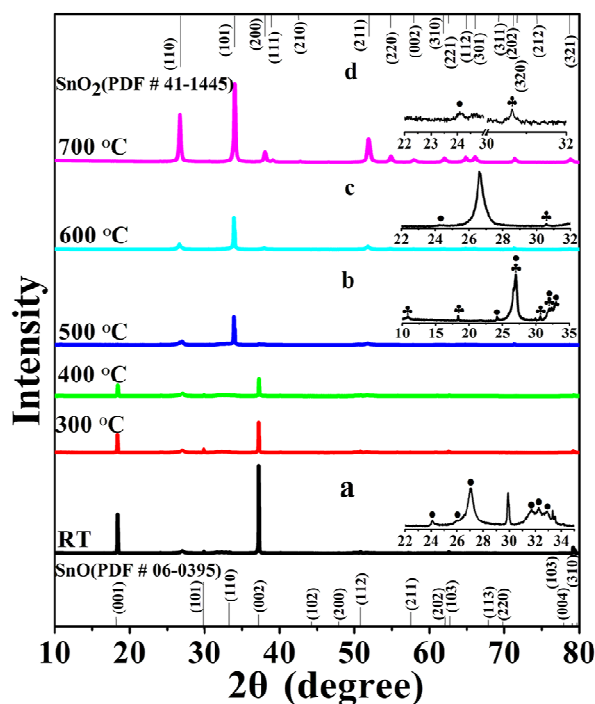
2 The aforementioned heterostructure microspheres with hollow structures were prepared
3 by a facile one step hydrothermal approach using sodium hydroxide, urea, and tin dichloride
4 dehydrate ($\text{SnCl}_2 \cdot 2\text{H}_2\text{O}$) as precursors. In a typical synthesis, 60 ml of absolute ethanol and
5 140 ml of deionized water were mixed in a 250 ml beaker and stirred to ensure complete
6 mixing. Then, 0.48 mM sodium hydroxide, 0.264 mM urea, and 0.04 mM tin dichloride
7 dehydrate were dissolved in the mixture and agitated for approximately 1 h. The resulting
8 mixture was transferred into a 200-ml sealed autoclave and heated in oven at 180°C for 18 h.
9 The product was then centrifuged several times alternately in deionized water and ethanol,
10 and the residual was dried for 10 h at 60°C in a vacuum stove. The final product was finally
11 annealed at 300, 400, 500, 600 and 700°C for 2 h under atmosphere.

12 The morphologies of the obtained products were characterized using a field-emission
13 scanning electron microscope (FESEM, s-4800II, Hitachi, 15kV). High resolution
14 transmission electron microscopy (HRTEM) images and selective area electron diffraction
15 (SAED) patterns were captured using a Tecanai G2 F30 S-Twin microscope at an accelerating
16 voltage of 300 kV. Crystallographic data were obtained using power X-ray diffraction
17 (Bruker, D8 Advance, Cu $k\alpha$ radiation, $\lambda = 1.5406 \text{ \AA}$). The phase composition of the
18 as-prepared product was analyzed using an Axis Ultra X-ray photoelectron spectroscope
19 (XPS, Kratos Analytical Ltd., UK) that was equipped with a standard monochromatic
20 Al- $k\alpha$ source ($h\nu = 1486.6 \text{ eV}$). The binding energy data were calibrated with respect to the
21 C1s signal of the ambient hydrocarbons (C-H and C-C) at 284.8 eV. The absorption
22 measurements were performed using a UV-vis-NIR spectrophotometer (UV-vis, Cary-5000,
23 Varian) with an integrating sphere.

24 Photocatalytic experiments were conducted on the as-prepared samples to decompose or
25 remove rhodamine B (RhB) aqueous solutions using the following procedure: 5 mg of the
26 as-prepared samples were suspended in 25 ml of an aqueous solution of $1 \times 10^{-5} \text{ mol/L}$ RhB.
27 Prior to irradiation, the suspensions were sonicated for 10 min and then magnetically stirred
28 in the dark for 30 min to attain desorption-adsorption equilibrium. The solution was then
29 exposed to UV irradiation from a mercury lamp (300 W) at room temperature. Five-milliliter

1 samples were collected every 30 min, centrifuged to remove the residual photocatalyst, and
 2 the upper clear liquid was analyzed by recording the maximum absorption band (554 nm for
 3 RhB) using a Shimadzu UV-3600 spectrophotometer. Also, 5 mg of commercial TiO₂ (P25)
 4 was used in the control experiment. Additionally, the recycle experiments were performed for
 5 five consecutive cycles with irradiation time of 150min under UV irradiation to test the
 6 durability and irradiation time was kep

7 III. Results and Discussion

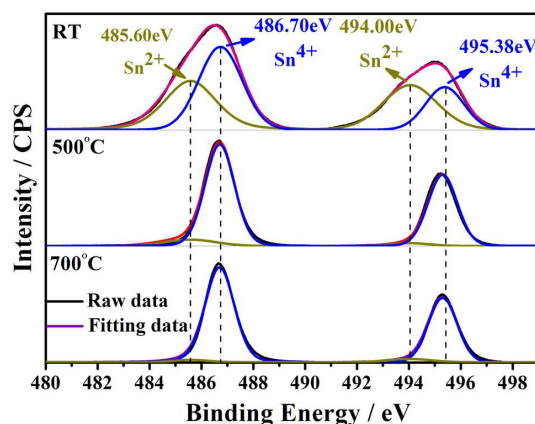


8

9 **Figure 1** XRD patterns of tin oxide-based powders before and after annealing at 300, 400, 500, 600,
 10 and 700 °C for 2 h in air; insets show expanded powder XRD patterns of samples before and after
 11 annealing at 500, 600, and 700 °C: inset (a) shows an enlarged spectrum, where peaks marked by (●)
 12 correspond to Sn₃O₄ (JCPDS 16-0737); inset (b) shows an enlarged spectrum, where peaks marked by (♣)
 13 correspond to other Sn₃O₄ phases (JCPDS 20-1293)

14 The XRD patterns of the as-prepared samples and the tin oxide-based powders formed at
 15 varying oxidation temperatures of 300, 400, 500, 600, and 700 °C are shown in figure 1. The
 16 as-prepared tin oxide-based powders that were annealed at temperatures of 300 and 400 °C
 17 exhibited two sharp diffraction peaks corresponding to the reflections of a tetragonal SnO
 18 phase (JCPDS 06-0395). A weak SnO peak was also observed at 29.989° (corresponding to

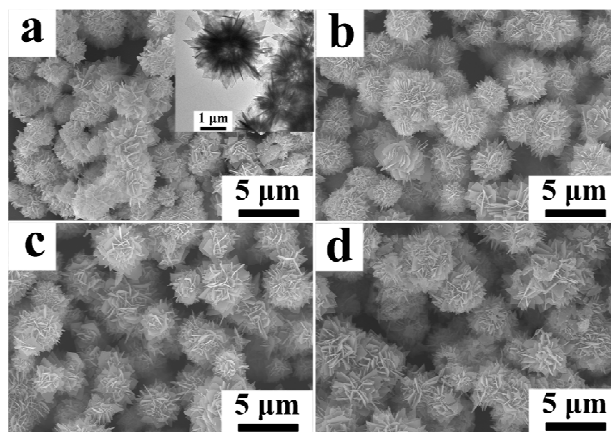
1 the (101) plane), indicating the simultaneous existence of the tetragonal SnO phase. Note that
 2 extra peaks from minor phases could also be identified. The inset in figure 1a is an enlarged
 3 spectrum over the 22° to 35° range. In addition to the SnO peaks, six characteristic peaks
 4 could be identified (which are marked by (●)) as (101), ($\bar{1}20$), (111), ($\bar{2}10$), ($\bar{1}21$), and
 5 (210) reflections from Sn₃O₄ (JCPDS 16-0737). Following annealing above 400 °C, the
 6 XRD spectra of samples changed dramatically. The peaks corresponding to SnO completely
 7 disappeared at 500 °C, and new dominant peaks appeared that were indexed to the tetragonal
 8 SnO₂ phase (JCPDS 41-1445), indicating the oxidation of SnO to SnO₂. The phase
 9 transformation process is discussed later (see experimental details in †ESI, S1). Furthermore,
 10 the intensities of the SnO₂ diffraction peaks increased with the annealing temperature. At 500
 11 and 600 °C, two typical Sn₃O₄ peaks were simultaneously present. In the inset of figure 1(b),
 12 the peaks marked by a (♣) were indexed to the (001), (100), (101), (111), (020), ($\bar{0}21$),
 13 and ($\bar{1}12$) reflections of Sn₃O₄ (JCPDS 20-1293). When the annealing temperature reached
 14 700 °C, the products were transformed into pure rutile-structured SnO₂, which was confirmed
 15 by fitting the SnO₂ peaks (JCPDS 41-445), as shown in the inset of figure 1 (d). Therefore, a
 16 phase transition from SnO to SnO₂ occurred along with the formation of an intermediate
 17 oxidation state of Sn₃O₄. The existence of Sn₃O₄ was confirmed by performing Raman
 18 spectroscopy to clarify the crystalline compositions and structures of the aforementioned
 19 samples (see experimental details in †ESI, S2).



20

21 **Figure 2** XPS spectra of Sn 3d for tin oxide-based powders before and after annealing at 500 and 700 °C
 22 for 2 h in air

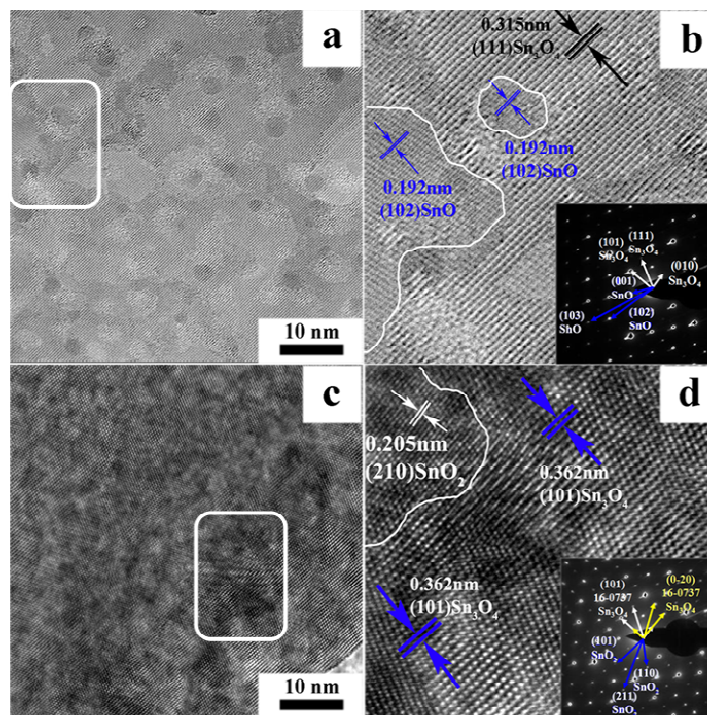
1 To gain insight into the evolution of the tin oxide during the annealing process, X-ray
2 photoelectron spectra (XPS) was performed to investigate the changes in the Sn-related states
3 under different annealing temperatures (see figure 2). The Sn 3d spectrum exhibited spin-orbit
4 doublet peaks at ≈ 486 eV ($\text{Sn}^{2+} 3d_{5/2}$) and ≈ 495 eV ($\text{Sn}^{2+} 3d_{3/2}$). After annealing above
5 500°C , the main peaks shifted to higher binding energies, which matched the binding energies
6 of Sn^{4+} (at 486.7 eV and 495.4 eV for $3d_{5/2}$ and $3d_{3/2}$, respectively) well, and the Sn^{4+} content
7 increased and gradually dominated the material composition. The binding energies of the
8 Sn-related states obtained in this experiment were consistent with the XRD results.



9
10 **Figure 3** SEM images of tin oxide-based microspheres (a) before and after annealing at (b) 300, (c) 500,
11 and (d) 700°C for 2 h in air; inset in (a) is a TEM image of the as-synthesized tin oxide microspheres

12 The product morphologies were studied by SEM. Figure 3 shows typical SEM images of
13 the collected tin oxide microspheres before and after annealing treatments at different
14 temperatures. Three-dimensional (3D) microspheres assembled into sheet-like subunits with
15 diameters ranging from 3 to $5\ \mu\text{m}$. TEM measurements were performed to characterize the
16 sample structures further and are shown in the inset of figure 3 (a). The obvious contrast
17 between the dark edges and the pale centers confirms that these microspheres were hollow. It
18 has been reported that this hollow structure can improve light harvesting through multiple
19 light reflections and scattering effects that can be used for applications in the
20 photo-decomposition of organic compounds. Furthermore, the morphology of the hollow

1 microsphere structures was faithfully preserved during the calcination process. Therefore,
 2 hollow microspheres can be synthesized on a large scale, where the shells of the microspheres
 3 are covered with numerous nanoflakes.



4
 5 **Figure 4** HRTEM images and SAED patterns of as-synthesized tin oxide-based heterostructures;
 6 lattice-resolved HRTEM images were taken from the edge of the microspheres obtained (a) before and (b)
 7 after annealing at 500 °C for 2 h in air; insets show corresponding SAED patterns

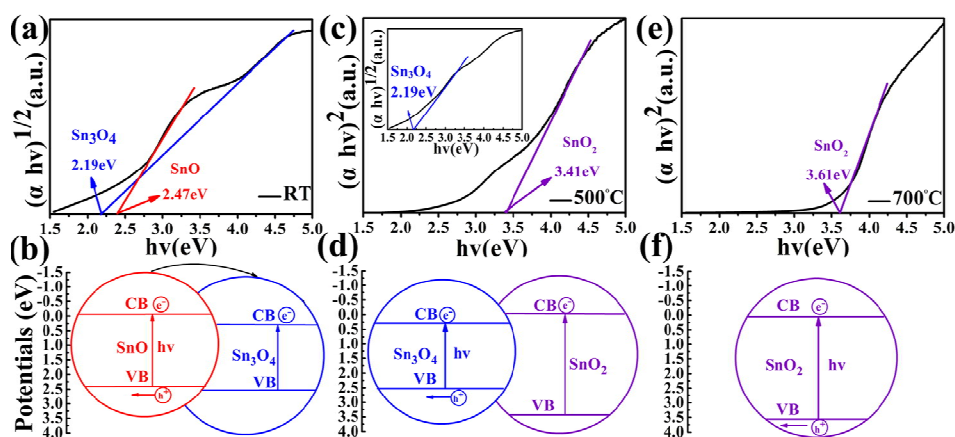
8 To obtain detailed information about the microstructure of the as-synthesized tin
 9 oxide-based microspheres, HRTEM observations and selected-area electron diffraction
 10 (SAED) analysis were carried out: the results are shown in figure 4. The SAED patterns in the
 11 insets of figure 4 show two different types of crystal phases in the samples: both phases of the
 12 heterostructures were crystalline. Meanwhile, the HRTEM images of the region that are
 13 marked by a white line confirmed the presence of crystalline SnO/Sn₃O₄ and SnO₂/Sn₃O₄
 14 crystal lattices in the interfacial region, as shown in figure 4. The HRTEM images also clearly
 15 revealed the in situ formation of heterostructures within the interface, which would have
 16 facilitated interfacial electron transfer and accordingly increased the photocatalytic activity.
 17 The aforementioned analysis confirmed that SnO/Sn₃O₄ and SnO₂/Sn₃O₄ composites with
 18 heterostructures formed in our prepared samples. Note that the SnO content in the SnO/Sn₃O₄

1 semiconductors disappeared as the annealing temperature increased until finally, only SnO₂
 2 was observed at 700 °C; thus, the annealing temperature could be tuned to adjust the tin oxides
 3 constituents to produce the required optical properties.

4 Typical UV-vis spectroscopy measurements were used to further confirm the formation of
 5 the heterostructures. In the literature^{30, 31}, SnO₂ has been reported to be a direct band gap
 6 material, and SnO and Sn₃O₄ have been reported to be indirect band gap materials: the optical
 7 band gap energy (E_g) of these materials can be calculated using the equation given below³²,

$$8 \quad \alpha h\nu = C(h\nu - E_g)^n,$$

9 where n is equal to 1/2 and 2 for direct allowed transitions and indirect transitions,
 10 respectively.



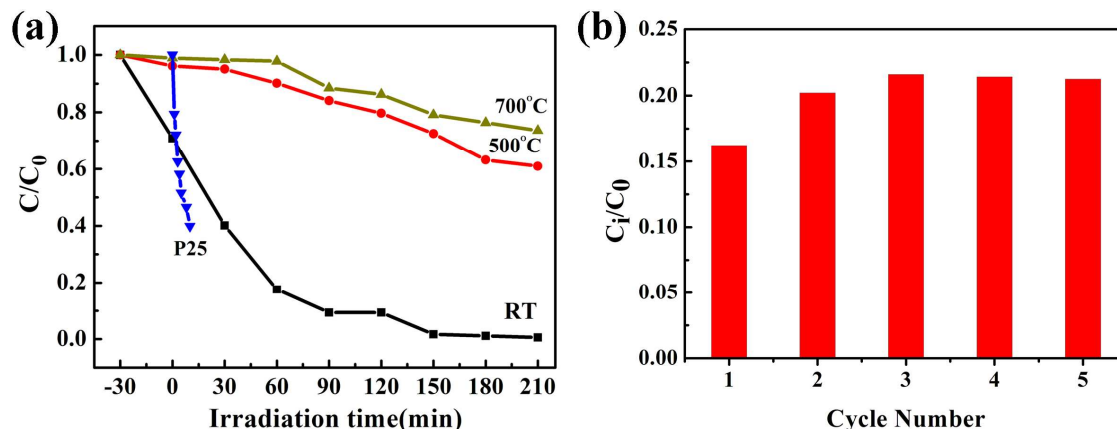
11
 12 **Figure 5** Plots of $(\alpha h\nu)^{n/2}$ vs. photon energy ($h\nu$) for (a) as-prepared tin oxide-based
 13 heterostructures and heterostructures formed at oxidation temperatures of (c) 500 and (e) 700 °C; (b), (d)
 14 and (f) are the corresponding schematic diagrams of the energy band structures of tin oxide-based
 15 heterostructures

16 The spectra of the SnO/Sn₃O₄ and SnO₂/Sn₃O₄ heterostructures are plotted in figure 5 (a
 17 and c): two slopes can be clearly observed that indicate the formation of heterostructures. The
 18 E_g values of SnO and Sn₃O₄ in the SnO/Sn₃O₄ heterostructures were evaluated as 2.47 and
 19 2.19 eV, respectively. Upon heating to 500 °C, the E_g values for SnO₂ and Sn₃O₄ in the
 20 SnO₂ /Sn₃O₄ heterostructures were evaluated as 3.41 and 2.19 eV, respectively. Meanwhile,
 21 further increasing the annealing temperature to 700 °C yielded only one slope in figure 5(e),

1 and the E_g was estimated at 3.61 eV, which was in agreement with the reported value for
 2 SnO₂ (3.5-3.7 eV). The valence band edge positions of the tin oxide-based heterostructures
 3 were estimated using electronegativity concepts. The valence band potentials of a
 4 semiconductor at the point of zero charge can be calculated using the following empirical
 5 equation^{33, 34, 35}:

$$6 \quad E_{VB} = X - E^e + 0.5E_g \quad (1),$$

7 where E_{VB} is the VB edge potential, and X is the electronegativity of the semiconductor,
 8 which is the geometric mean of the electronegativity of the constituent atoms. The X values
 9 for SnO, SnO₂ and Sn₃O₄ are 5.68, 6.24 and 5.91 eV, respectively. The energy of the free
 10 electrons on the hydrogen scale is denoted by E^e (≈ 4.5 eV), E_g is the band gap energy of
 11 the semiconductor, and E_{CB} can be determined from $E_{CB} = E_{VB} - E_g$. Figure 5 (b, d, and f)
 12 shows the schematic diagrams of the energy band structures of the tin oxide-based
 13 heterostructures. Sn₃O₄ exhibited a narrower band gap than the band energy alignment of SnO
 14 and SnO₂, and the valence and conduction band alignments for Sn₃O₄ were staggered relative
 15 to those of SnO and SnO₂; therefore SnO/Sn₃O₄ was a type-II heterostructure. In SnO₂/Sn₃O₄,
 16 the band gap Sn₃O₄ was embedded in that of SnO₂; thus, SnO₂/Sn₃O₄ was a type-I
 17 heterostructure.



18 **Figure 6** (a) Comparison of photocatalytic degradation of RhB in the presence of tin oxide-based
 19 heterostructures; (b) Cycling runs for the photocatalytic degradation of RhB over SnO/Sn₃O₄ under UV
 20 irradiation
 21

1 The photocatalytic activities of the as-synthesized different heterostructures were
2 evaluated by the degradation of a RhB dye in water under UV light irradiation, as shown in
3 figure 6(a). Figure 6(a) shows the absorption spectra of the RhB solution in the presence of tin
4 oxide-based semiconductors. Figure 6(a) shows that the tin oxide-based heterostructures
5 SnO/Sn₃O₄ and SnO₂/Sn₃O₄ exhibited a better catalytic degradation than SnO₂, whereas the
6 SnO/Sn₃O₄ heterostructure semiconductors performed the most efficient degradation of RhB.
7 The poor performance of SnO₂ semiconductors could be attributed to the low negative
8 conduction potential of SnO₂, because the conduction band bottom potential of SnO₂ is near
9 that of O₂/O²⁻ (-0.046 eV vs. SHE), indicating that SnO₂ readily undergoes photocorrosion in
10 aqueous media containing oxygen and that the over potential is too small to reduce O₂ with
11 photoexcited electrons³⁶; therefore, photocatalytic degradation using SnO₂ was not effective.
12 For practical photocatalytic applications, the recycling of photocatalyst is very important. In
13 the durability tests, SnO/Sn₃O₄ was repeatedly used for the RhB photodegradation reaction 5
14 times (Figure 6 (b)). The experimental results indicated that no apparent deactivation of
15 photocatalyst is seen after 5 cycles as compared to the fresh catalyst.

16 Catalytic degradations of dye have been reported in the literature^{37, 38}. For SnO/Sn₃O₄ with
17 a type-II heterostructure, electrons could be excited from the valence bands to the conduction
18 bands of SnO semiconductors by UV irradiation because of the band offset: the generated
19 electrons on the conduction band of SnO were directly injected into the conduction band of
20 Sn₃O₄, whereas the holes remained on the valence band (as shown in Fig. 5b). Thus, more
21 electrons accumulated in the conduction band of the SnO, resulting in more holes in the
22 valence band of SnO, i.e., interfacial charge separation occurred. The electrons that were
23 eventually localized in the conduction band of Sn₃O₄ reduced O₂ to form superoxide ions
24 *O₂⁻, and the holes located in the valence band of SnO reacted with the hydroxyl group to
25 produce the hydroxyl radicals (*OH) that degraded RhB in the photoreaction. The high
26 efficient photodegradation activity of SnO/Sn₃O₄ can be explained as, on the one hand, the
27 morphology of SnO/Sn₃O₄ exhibits a high surface-to-volume ratio, which is benefit to the
28 adsorption of dye RhB molecules, the photodegradation efficiency will improve; on the other
29 hand, the life span of photogenerated electron-hole pair is large enough to migrate and is
30 available for redox reactions at photocatalyst surface, as the recombination rate of the electron

1 and hole excited from indirect semiconductor SnO is lower than that of the direct
2 semiconductor, which will be favorable for the charge separation. Therefore, the samples
3 SnO/Sn₃O₄ prepared at room temperature show a high efficient photodegradation activity, as
4 shown in Figure 6.

5 For the type-I SnO₂/Sn₃O₄ heterostructure, electrons were excited upon light irradiation of
6 both the SnO₂ and Sn₃O₄ semiconductors. Then, unlike in the type-II heterostructures, more
7 electrons and holes recombined while electrons and holes were produced for both the SnO₂
8 and Sn₃O₄ semiconductors, resulting in a photocorrosion effect as the electrons and holes
9 recombined in the conduction and valence bands of SnO₂ and Sn₃O₄. Sn₃O₄ is an indirect
10 semiconductor; therefore, the recombination rate of the indirect semiconductor was relatively
11 lower, and some electrons and holes participated in the photocatalytic degradation of RhB
12 before recombination, which explains why the type-I SnO₂/Sn₃O₄ heterostructure had a much
13 higher photocatalytic degradation effect than the SnO₂ semiconductor. The degradation
14 efficiency of a photocatalyst can be defined as follows³⁹:

$$15 \quad \text{Degradation}(\%) = (1 - C/C_0) \times 100\% \quad (2),$$

16 where C_0 is the RhB concentration at equilibrium adsorption, and C is the residual
17 concentration of RhB at different illumination intervals. The photodegradation of RhB
18 follows pseudo-first-order kinetics, which can be expressed as follows:

$$19 \quad \ln(C/C_0) = -kt \quad (3),$$

20 where k (min^{-1}) is the degradation rate constant. Equation (3) was used to calculate the
21 degradation rate constants of 2.3×10^{-3} and $3.6 \times 10^{-5} \text{ min}^{-1}$ for the SnO/Sn₃O₄ and SnO₂/Sn₃O₄
22 semiconductors, respectively. Although the degradation rate constant for SnO/Sn₃O₄ is much
23 smaller than the P25 (9.2×10^{-2}). We believe that our report provides a new approach to
24 realize high Efficiency Photocatalytic of heterostructures of type-II univalent tin oxides.
25 Therefore, enhanced photocatalytic degradation of RhB solutions was observed using
26 SnO/Sn₃O₄ with type-II heterostructures as photocatalysts, as shown in Figure 6. The
27 observed phenomenon was consistent with other reports.⁴⁰ Furthermore, the flower-like

1 hollow microspheres is still inherited after five consecutive cycles (See Figure S3 in the
2 supporting Information).

5 **IV. Conclusions**

6 In summary, tin oxide semiconductors with a morphology of flower-like hollow
7 microspheres were synthesized using a one-step hydrothermal route and a series of annealing
8 processes. The as-prepared products were characterized by XRD, scanning electron
9 microscopy (SEM), high resolution transmission electron microscopy (HRTEM), X-ray
10 photoelectron spectroscopy (XPS), and UV-vis diffuse reflectance spectra. Systematic
11 measurements revealed that the as-prepared flower-like hollow microspheres had a type-II
12 SnO/Sn₃O₄ heterostructure. After a 500 °C annealing treatment, the original SnO/Sn₃O₄
13 heterostructure changed into SnO₂/Sn₃O₄ with a type-I heterostructure, and the products were
14 SnO₂ at 700 °C. The original prepared SnO/Sn₃O₄ semiconductors with type-II heterostructures
15 performed the highest efficiency degradation of rhodamine B (RhB) with a degradation rate
16 constant of $2.3 \times 10^{-3} \text{ min}^{-1}$. This highly efficient activity was induced by the enhanced charge
17 separation in the SnO/Sn₃O₄ semiconductors with type-II heterostructure. This typical hollow
18 structure has two advantages for photocatalytic activity: the structure has a high
19 surface-to-volume ratio, which enables multi-reflections of irradiated light within the interior
20 cavities, and the products consist of two phases of homologous tin oxides. We believe that our
21 prepared SnO/Sn₃O₄ and SnO₂/Sn₃O₄ heterostructures microspheres can be used as
22 visible-light-driven high-performance photocatalysts. Studies on such applications are
23 currently underway.

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3

4

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